Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,541	CHANG, YI-HUI
Examiner	Art Unit
James W. Cranson	2875

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SEARCHED					
Class	Subclass	Date	Examiner		
362	31	5/16/2005	JWC		
362	26	5/16/2005	JWC		
362	561	5/16/2005	JWC		
349	65	5/16/2005	JWC		
362	555	5/16/2005	JWC		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
362	31	5/16/2005	JWC		
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		DATE	EXMR
362/\$.ccls.	·	1/29/2005	JWC
349/\$.ccls.		1/29/2005	JWC
315/\$.ccls.			JWC
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